

MOSFET – Power, Single, N-Channel

80 V, 2.1 mΩ, 203 A

NTMFS6H800N

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	80	V
Gate-to-Source Voltage	€		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	203	Α
Current R _{0JC} (Notes 1, 3)	Steady	T _C = 100°C		143	
Power Dissipation	State	T _C = 25°C	P _D	200	W
R _{θJC} (Note 1)		T _C = 100°C	1	100	
Continuous Drain	Steady State	T _A = 25°C	I _D	28	Α
Current R _{θJA} (Notes 1, 2, 3)		T _A = 100°C		20	
Power Dissipation		T _A = 25°C	P _D	3.8	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C	1	1.9	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 175	°C
Source Current (Body Diode)			I _S	166	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 16.1 A)			E _{AS}	1271	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

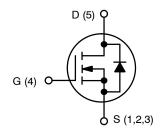
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

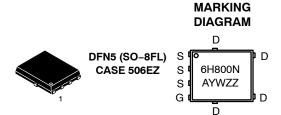
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.75	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
80 V	2.1 m Ω @ 10 V	203 A	



N-CHANNEL MOSFET



A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				39		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10	
		V _{DS} = 80 V	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	s = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 330 μΑ	2.0		4.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				8.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		1.8	2.1	
		V _{GS} = 6 V	I _D = 50 A		2.6	3.5	mΩ
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I _D	= 50 A		138		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 40 V			5530		pF
Output Capacitance	C _{OSS}				760		
Reverse Transfer Capacitance	C _{RSS}				27		
Output Charge	Q _{OSS}				116		nC
Total Gate Charge	Q _{G(TOT)}				85		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 50 A			15		nC V
Gate-to-Source Charge	Q_GS				26		
Gate-to-Drain Charge	Q_GD				16		
Plateau Voltage	V_{GP}				4.8		
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(ON)}				25		
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	s = 64 V,		89		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 50 \text{ A}, R_G = 2.5 \Omega$			97		ns -
Fall Time	t _f				85		
DRAIN-SOURCE DIODE CHARACTERIST	ics					•	•
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.8	1.2	\ , .
		I _S = 50 A	T _J = 125°C		0.7		_ v
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			76		
Charge Time	t _a				36		ns
Discharge Time	t _b				40		1
Reverse Recovery Charge	Q _{RR}				82		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

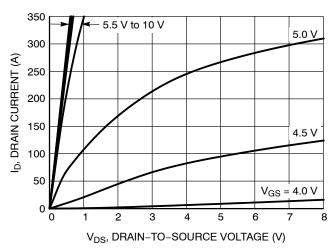


Figure 1. On-Region Characteristics

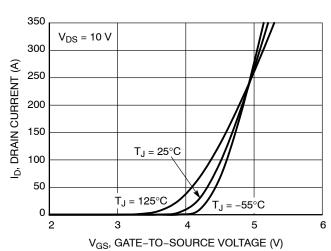


Figure 2. Transfer Characteristics

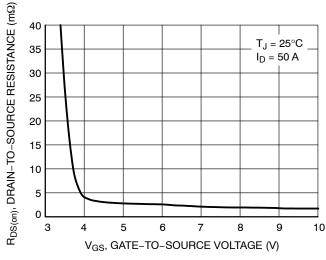


Figure 3. On-Resistance vs. Gate-to-Source Voltage

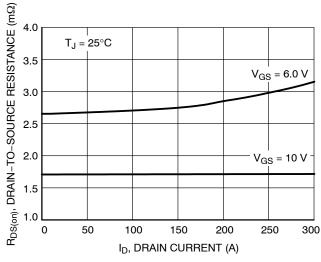


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

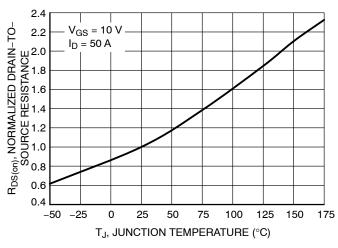


Figure 5. On–Resistance Variation with Temperature

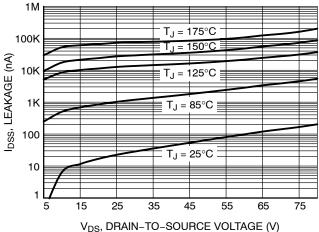


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

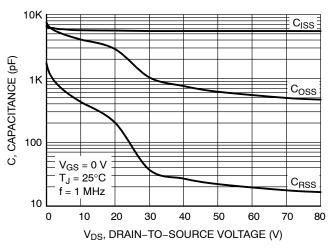


Figure 7. Capacitance Variation

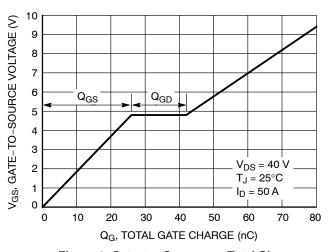


Figure 8. Gate-to-Source vs. Total Charge

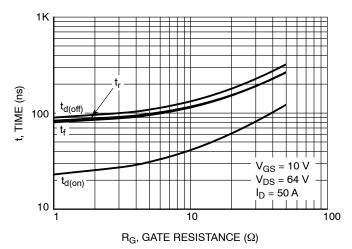


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

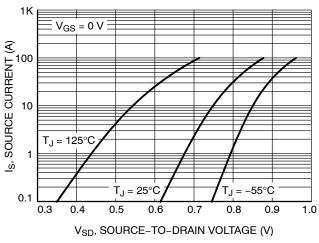


Figure 10. Diode Forward Voltage vs. Current

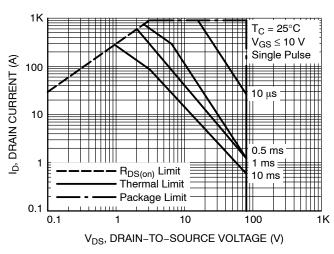


Figure 11. Maximum Rated Forward Biased Safe Operating Area

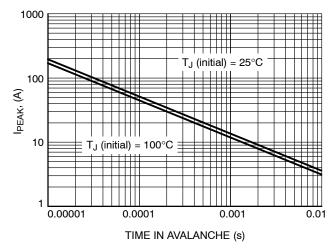


Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

TYPICAL CHARACTERISTICS

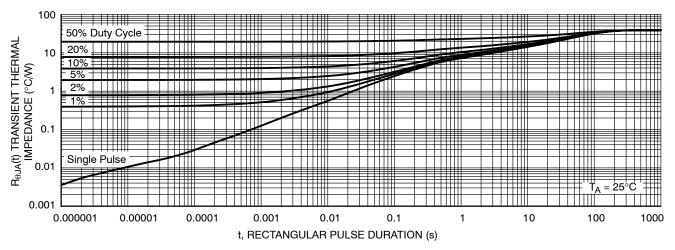


Figure 13. Thermal Response

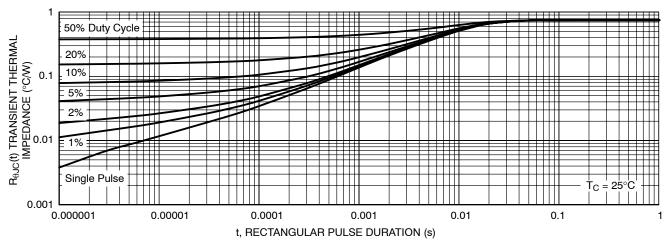


Figure 14. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMFS6H800NT1G	6H800N	DFN5 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SCALE 2:1





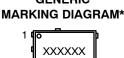
DATE 25 AUG 2021

MILLIMETERS

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	d I III	I I	I			
			DIM	MIN.	N□M.	MAX.
PIN 1 IDENTIFIER —			Э А	0.90	1.00	1.10
1	i i	i	A1	0.00		0.05
			b	0.33	0.41	0.51
٩				0.23	0.28	0.33
·		A1- I Y	ם ו	5.00	5.15	5.30
	TOP VIEW		EATING D1	4.70	4.90	5.10
	101 112 11		D2	3.80	4.00	4.20
	DETAIL A —		E	6.00	6.15	6.30
// 0.10 C	$\overline{}$		E1	5.70	5.90	6.10
4		‡	E2	3.45	3.80	3.85
□ 0.10 C			e		1.27 BSC	,
	SIDE VIEW	SEATING C PLANE	G	0.51	0.575	0.71
	OIDL VILW		k	1.10	1.20	1.40
8X b	-		L	0.51	0.575	0.71
⊕ 0.10 C A B 0.05 C			L1		0.125 RE	F
[* [0.05[C]	 e		М	3.00	3.40	3.80
	 e/2		θ	0*		12*
<u>1</u> 		K	2X 0.4950→	2× 1.53-	56 	
i 🕏		PACKAGE	: -2X 0.25	TIF	 	

(EXPOSED PAD) **GENERIC** BOTTOM VIEW



PACKAGE DUTLINE

2X 0.91

0.97

4X 1.00

4X 0.75-



= Year

= Work Week

Α Υ

W

ZZ

= Assembly Location

RECOMMENDED MOUNTING FOOTPRINT

_ 1.27 PITCH

For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

= Lot Traceability *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

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